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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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# Fast switching diode chip in Emitter Controlled Technology

## Features:

- 1200V technology 120 μm chip
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient
- qualified according to JEDEC for target applications

## Recommended for:

 power modules and discrete devices



# **Applications:**

SMPS, resonant applications, drives

Chip Type	<b>V</b> <sub>R</sub>	<i>I</i> <sub>Fn</sub>	Die Size	Package
SIDC06D120F6	1200V	5A	2.45 x 2.45 mm <sup>2</sup>	sawn on foil

#### **Mechanical Parameters**

Mconamour r aramete	<u> </u>			
Die size		2.45 x 2.45		
Area total		6	mm²	
Anode pad size		1.73 x 1.73		
Thickness		120	μm	
Wafer size		150	mm	
Max. possible chips pe	er wafer	2520		
Passivation frontside		Photoimide		
Pad metal		3200 nm AlSiCu		
Backside metal		Ni Ag –system		
Die bond		Electrically conductive epoxy glue and soft solder		
Wire bond		Al, ≤500μm		
Reject ink dot size		Ø 0.65mm; max 1.2mm		
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, Temperature 17°C – 25°C < 6 month		
	for open MBB bags	Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert Humidity <25%RH, Temperature 17°C – 25°C, < 6 more		



# **Maximum Ratings**

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V <sub>RRM</sub>	T <sub>vj</sub> = 25 °C	1200	V
Continuous forward current	I <sub>F</sub>	<i>T</i> <sub>vj</sub> < 150°C	1)	_
Maximum repetitive forward current <sup>2)</sup>	I <sub>FRM</sub>	<i>T</i> <sub>vj</sub> < 150°C	10	Α
Operating junction and storage temperature	$T_{\rm vj,} T_{\rm stg}$		-55+150	°C

<sup>1)</sup> depending on thermal properties of assembly

# **Static Characteristics** (tested on wafer), $T_{vj} = 25 \, ^{\circ}\text{C}$

Parameter	Symbol	Conditions	Value			Unit
rarameter		Conditions	min.	typ.	max.	Oilit
Reverse leakage current	I <sub>R</sub>	$V_{R} = 1200 \mathrm{V}$			20	μΑ
Cathode-Anode breakdown Voltage	V <sub>BR</sub>	I <sub>R</sub> =0.25mA	1200			V
Forward voltage drop	$V_{F}$	/ <sub>F</sub> =5A	1.68	2.1	2.42	

# Electrical Characteristics (not subject to production test - verified by design/characterization)

Parameter		Symbol Conditions	Conditions	Value			Unit
			min.	typ.	max.	Oilit	
Forward voltage drop	<i>T</i> <sub>vj</sub> = 125°C	V <sub>F</sub>	I <sub>F</sub> =5A		1.8		V

## **Further Electrical Characteristics**

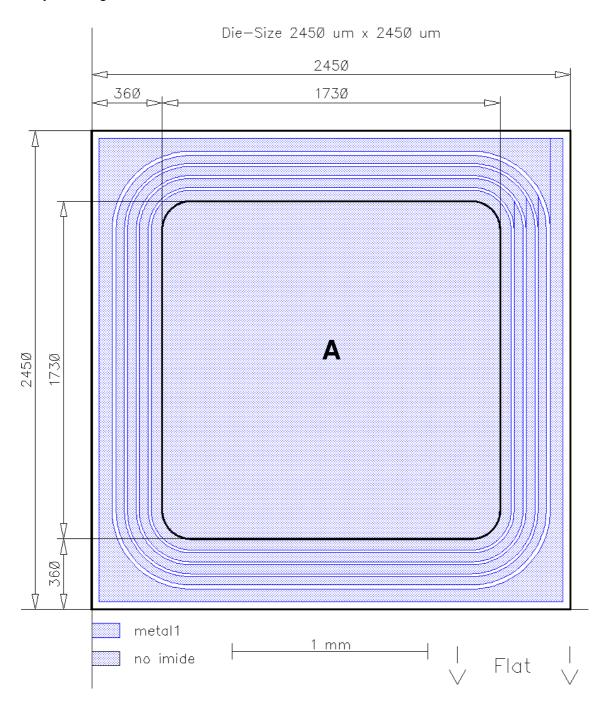
Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

This chip data sheet refers to the device data sheet	
	1

<sup>&</sup>lt;sup>2)</sup> not subject to production test - verified by design/characterisation



# **Chip Drawing**



A: Anode pad



# **Description**

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

## **Revision History**

Version	Subjects (major changes since last revision)	Date	
2.0	Final data sheet	26.10.2012	
2.1	Operating junction and storage temperature	14.05.2013	

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